



1/31/06

SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
065933-0084

SERIAL NO.
10/813,629

APPLICANT
Ryosuke USUI, et al.

FILING DATE
March 31, 2004

GROUP
2814

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code: (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US			
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No
<i>NR</i>		JP 10-284648	10-23-1998	Hitachi, Ltd		X

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
		Notification of Reasons for Rejection; Dispatch Date: October 31, 2005; Patent Application No. 10-2004-21647; Title Semiconductor Module and Method of Manufacturing the Same

EXAMINER

Detras Moyer

DATE CONSIDERED

6/20/06

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION			ATTY. DOCKET NO. 65933-084		SERIAL NO.	
			APPLICANT Ryosuke USUI, et al.			
(PTO-1449)			FILING DATE March 31, 2004		GROUP	
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EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code(s) (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
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<i>DL-1</i>		JP 2002-110717 A (w/ English Abstract)	04/12/2002	SANYO ELECTRIC CO., LTD.		
<i>DL-7</i>		JP 2002-94247 A (w/ English Abstract)	03/29/2002	SONY CORP.		
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				
EXAMINER <i>Delores Skye</i>			DATE CONSIDERED <i>6/20/06</i>			

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